

Industrial Consultancy & Sponsored Research (IC&SR)

System and Method for Ultrasonic Inspection of Curved Surfaces

IITM Technology Available for Licensing

Problem Statement

- **Pulsed Array Ultrasonic Transducers (PAUT)**, an existing **ultrasonic testing method** rely on multiple transducers and intricate electronic systems, resulting in **complexity, potential limitations in inspecting materials with curved portions, higher costs** and may limit its applications in diverse fields.
- The existing ultrasonic testing methods, including **advancements like curved array probes and conformable array transducers**, often come with inherent **complexities & costs**.
- Hence, there is a growing demand for a **more simpler, streamlined and cost-efficient solution for ultrasonic inspection**, especially for hollow structures to overcome the limitations of current technology.

Technology Category/ Market

Non-Destructive Testing Methods and Equipment (NDT/NDE) | Other Technologies

Industry: Manufacturing & Fabrication Industry, Healthcare, Aerospace, Oil and Gas Industry, Construction and Infrastructure Industry

Applications: Ultrasonic Inspection Technology, Non-Destructive Testing, Biomedical Ultrasound Imaging, Industrial Inspection Market

Market: The global ultrasonic testing market size is projected to grow from **\$ 1,954.4 million in 2020** and to reach **\$3,671.9 million by 2027**, growing at **9.43% CAGR from 2020 to 2027**.

Technology

The present patent invention aims to disclose a System and Method to streamline and cost-effectively improve **ultrasonic inspection for curved surfaces**, ensuring high-quality evaluations, especially in hollow structures and materials with curved portions.

Intellectual Property

IITM IDF No.: **1729** | IP No.: **402425 (Granted)**

TRL (Technology Readiness Level)

TRL-3: Proof of Concept

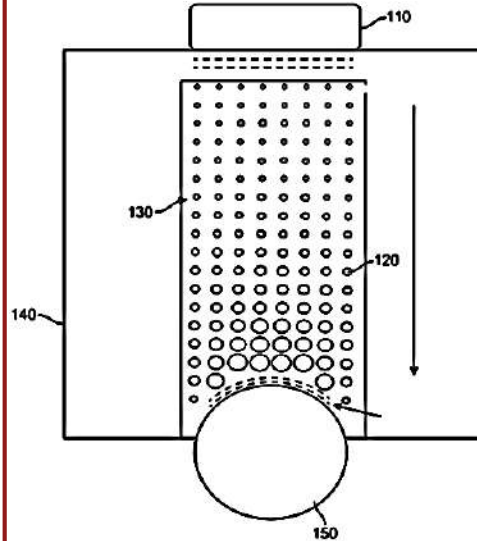
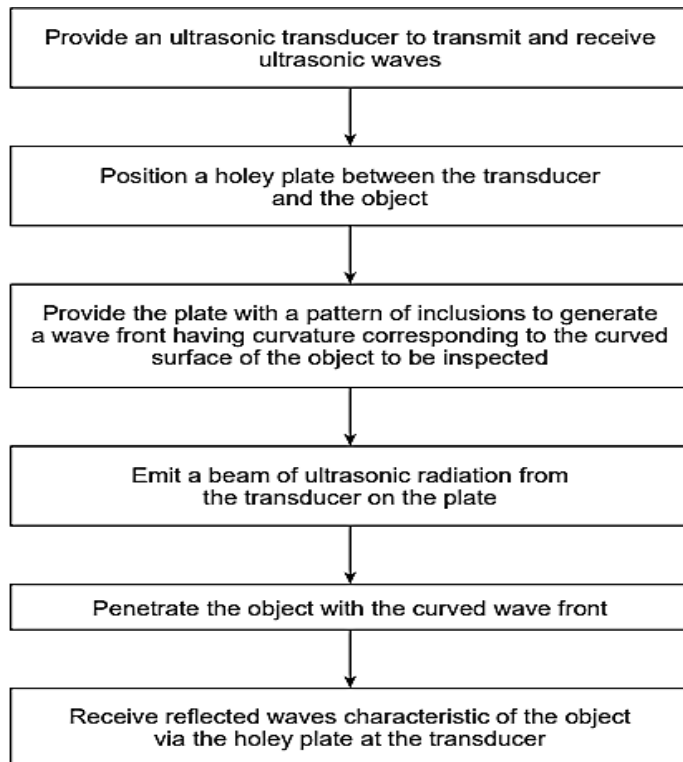


FIG. 1 Shows a system for ultrasonic inspection of curved surface.

FIG. 2 Shows a method for ultrasonic inspection of curved surface



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Key Features / Value Proposition

User perspective:-

- **Simplicity and Ease of Use:** User-friendly design and operation for easy implementation and reduced training requirements.
- **High-Quality Inspections:** Ensures accurate and reliable inspection results for curved surfaces without compromising quality.

Industrial perspective:-

- **Cost-Effective Solution:** Reduces overall costs associated with ultrasonic inspection by eliminating need for multiple transducers and complex electronics.
- **Versatility:** Applicable across various industries, offering a versatile solution for inspecting curved surfaces in different materials and structures.

Technology perspective:-

- **Single Transducer Efficiency:** Utilizes a single transducer for generating curved wave fronts, simplifying the technology and reducing complexity.
- **Customization with GRIN PCs:** Incorporates Gradient Refractive Index Phononic Crystals (GRIN PCs) for tailored wave front curvature, enhancing customization capabilities.

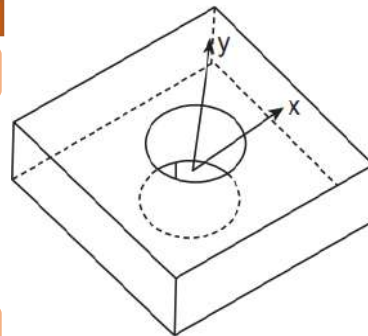


FIG. 4 shows the square unit cell having a circular shape inclusion with air medium

FIG. 5A shows A-scan plot of the inspected curved surface when the emitted ultrasonic wave passes through the holey plate.

FIG. 5B shows A-scan plot of the inspected curved surface when the emitted ultrasonic wave passes through a solid plate.

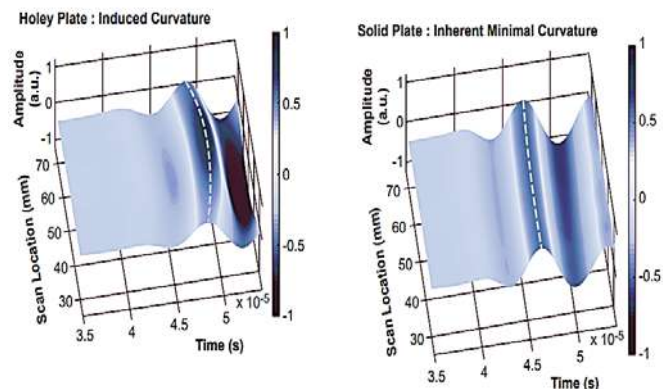


FIG. 6A shows a wave front before passing through a holey region;

FIG. 6B shows the wave front while passing through the holey region;

FIG. 6C shows the wave front after passing through the holey region.

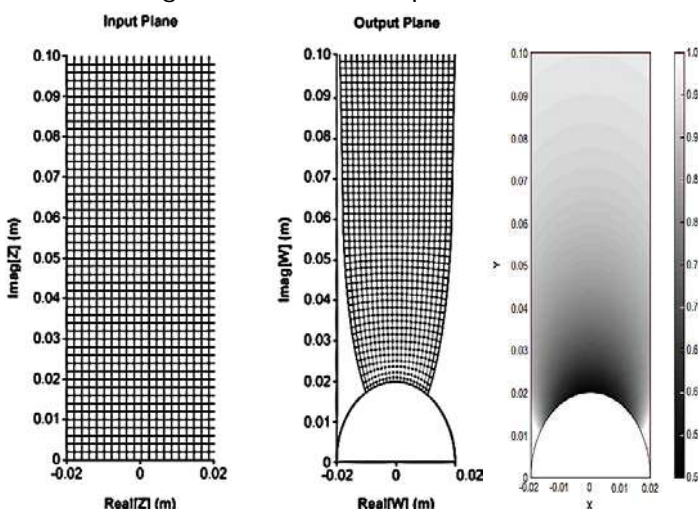
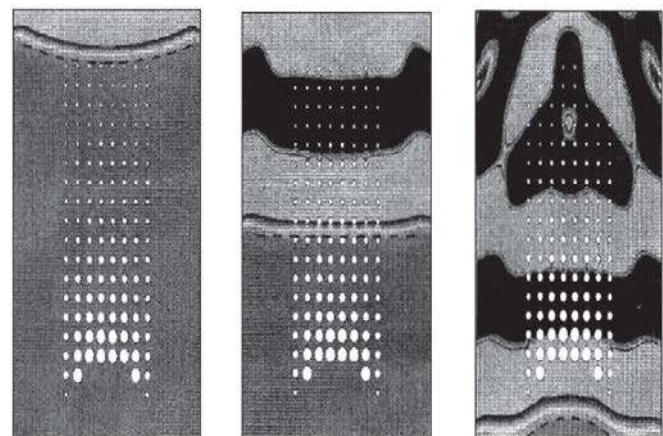


FIG. 3A shows parallel grid lines in virtual space;

FIG. 3B shows transformation of parallel grid lines in virtual space to a curved lines in physical space.

FIG. 3C shows the ratio of velocity required in the holey region to velocity of the wave in base medium.

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